

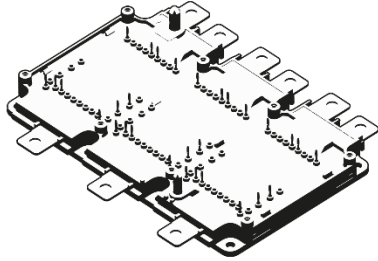
PRELIMINARY DATASHEET 初版规格书

SCSS002EVD120MS

EVD-Type three-phase 1.2kV SiC module; EVD封装半桥SiC模块

$V_{DSS} = 1200\text{ V}$

$R_{Dson} = 2.1\text{ m Ohm @ } I_D = 520\text{ A}$



- 3rd generation SiC MOSFET chips; 第三代 SiC MOSFET 芯片
- Ultra-low R_{Dson} ; 超低 R_{Dson}
- Low switching losses, Qg and Crss; 开关损耗低
- Low inductance module < 9nH; 低电感模块 < 9nH
- $T_{vj_op} = 175^\circ\text{C}$
- 4.2kV DC 1 sec insulation
- Compact design; 设计紧凑
- Direct cooled PinFin baseplate; 直接冷却 PinFin 底板
- High performance Si_3N_4 ceramic substrates
- Guiding elements for PCB and cooler assembly
- Integrated NTC temperature sensor; 集成式 NTC 温度传感器
- Press-fit contact technology
- RoHS compliant; 符合 RoHS 标准

Maximum ratings 最大额定值¹

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件	MIN 最小值	MAX 最大值	UNIT 单位
Drain – source voltage 漏极 – 源极电压	V_{DSS}	$V_{GS} \leq 0\text{ V}, T_{vj} = 25^\circ\text{C}$		1200	V
Continuous drain and source current 漏极和源极连续电流	I_D, I_S	$T_F = 60^\circ\text{C}, V_{GS} = 18\text{ V}, T_{vj} = 175^\circ\text{C}$		520	A
Peak drain and source current 漏极和源极峰值电流	I_{DM}, I_{SM}	$t_p = 1\text{ ms}$, limited by T_{vjmax}		1500	A
Gate-source voltage (DC) 栅源电压 (直流)	V_{GSS}		-10	22	V
Gate-source surge voltage 栅源浪涌电压	$V_{GSS\ surge}$	$t_{surge} < 300\text{ ns}$	-11	25	V
Recommended gate voltage 建议栅极电压	V_{GS}		-2	18	V
Surge current 浪涌电流				TBD	A
MOSFET SCSOA	t_{psc}	$V_{DS} = 800\text{ V}, V_{GSon} = 18\text{ V}, T_{vj} < 175^\circ\text{C}$		0	μs
Isolation voltage 绝缘电压	V_{isol}	RMS, 1 s, f = 50 Hz		4200	V
Junction operating temperature 运行结温	$T_{vj(op)}$		-40	175	$^\circ\text{C}$
Storage temperature 存储温度	T_{stg}		-40	125	$^\circ\text{C}$
Mounting torques for module mounting 紧固力矩 ²	M	Screw M4 baseplate to heatsink	1.8	2.2	Nm
Max pressure in cooling circuit 冷却回路最大压力	p	$T_{baseplate} < 40^\circ\text{C}$		2.5	bar
		$T_{baseplate} > 40^\circ\text{C}$		2.0	bar



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¹ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747; 根据标准 IEC 60747 要求, 最大额定值表示超过该限值可能会对器件造成损坏

² For details, please refer to the mounting instructions. 详细信息, 请参考安装说明书

MOSFET³

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件	MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Drain-source breakdown voltage 漏极-源极击穿电压	$V_{(BR)DSS}$	$V_{GS} < / = 0 \text{ V}$, $I_D = 10 \text{ mA}$, $T_{vj} = -40 \dots 25^\circ\text{C}$	1200			V
Static drain-source on-state resistance⁴ 静态漏极-源极导通电阻	$R_{DS(on)}$	$I_D = 600 \text{ A}$, $V_{GS} = 18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	2.1	2.7	$\text{m}\Omega$
			$T_{vj} = 175^\circ\text{C}$	3.8		$\text{m}\Omega$
Zero gate voltage drain current 零栅极电压漏极电流	I_{DSS}	$V_{DS} = 1200 \text{ V}$, $V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		60	μA
			$T_{vj} = 175^\circ\text{C}$			μA
Gate leakage current 栅极漏电流	I_{GSS}	$V_{GS} = +22 / -10 \text{ V}$	-500		500	nA
Gate-emitter threshold voltage 栅极-发射极阈值电压	$V_{GS(th)}$	$V_{GS} = V_{DS}$, $I_D = 60 \text{ mA}$	$T_{vj} = 25^\circ\text{C}$	1.9	3.9	V
			$T_{vj} = 175^\circ\text{C}$		2	V
Gate charge 栅极电荷	Q_G	$I_D = 500 \text{ A}$, $V_{DS} = 800 \text{ V}$, $V_{GS} = -2 \text{ V} \dots 18 \text{ V}$		1		μC
Input capacitance 输入电容	C_{iss}	$V_{DS} = 800 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 100 \text{ kHz}$, $T_{vj} = 25^\circ\text{C}$		29.8		nF
Output capacitance 输出电容	C_{oss}			1.2		nF
Reverse transfer capacitance 反向传输电容	C_{rss}			0.12		nF
Internal gate resistor 栅极内阻	R_{Gint}		Per switch		0.2	
Turn-on delay time 开通延迟	$t_{d(on)}$	$V_{CC} = 800 \text{ V}$, $I_D = 500 \text{ A}$, $R_G = 5 \Omega$, $V_{GS} = -4 / +18 \text{ V}$, $L_S = 30 \text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	56		ns
			$T_{vj} = 125^\circ\text{C}$	50		ns
			$T_{vj} = 175^\circ\text{C}$	47		ns
Rise time 上升时间	t_r		$T_{vj} = 25^\circ\text{C}$	58		ns
			$T_{vj} = 125^\circ\text{C}$	48		ns
			$T_{vj} = 175^\circ\text{C}$	44		ns
Turn-off delay time 关断延迟	$t_{d(off)}$	$V_{CC} = 800 \text{ V}$, $I_D = 500 \text{ A}$, $R_G = 7 \Omega$, $V_{GS} = -4 / +18 \text{ V}$, $L_S = 30 \text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	400		ns
			$T_{vj} = 125^\circ\text{C}$	445		ns
			$T_{vj} = 175^\circ\text{C}$	465		ns
Fall time 下降时间	t_f		$T_{vj} = 25^\circ\text{C}$	57		ns
			$T_{vj} = 125^\circ\text{C}$	59		ns
			$T_{vj} = 175^\circ\text{C}$	61		ns
Turn-on switching energy 开通损耗	E_{on}	$V_{CC} = 800 \text{ V}$, $I_D = 500 \text{ A}$, $R_G = 5 \Omega$, $V_{GS} = -4 / +18 \text{ V}$, $L_S = 30 \text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	26		mJ
			$T_{vj} = 125^\circ\text{C}$	19		mJ
			$T_{vj} = 175^\circ\text{C}$	18		mJ
Turn-off switching energy 关断损耗	E_{off}	$V_{CC} = 800 \text{ V}$, $I_D = 500 \text{ A}$, $R_G = 7 \Omega$, $V_{GS} = -4 / +18 \text{ V}$, $L_S = 30 \text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	39		mJ
			$T_{vj} = 125^\circ\text{C}$	39		mJ
			$T_{vj} = 175^\circ\text{C}$	39		mJ
Short circuit current 短路电流	I_{SC}	$t_{pCS} \leq 0 \mu\text{s}$, $V_{GE} = 18 \text{ V}$, $T_{vj} = 175^\circ\text{C}$, $V_{CC} = 800 \text{ V}$, $V_{DSM \text{ chip}} \leq 1200 \text{ V}$		-		A

³ Characteristic values according to IEC 60747-9

⁴ Given at chip level

Body diode⁵

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Forward voltage ⁶ 正向压降	V _{SD}	I _D = -500 A, V _{GS} = 18 V	T _{vj} = 25 °C		1		V
			T _{vj} = 175 °C		2.5		V
							V
Peak reverse recovery current 反向恢复电流峰值	I _{rr}	V _R = 800 V, I _{SD} = 500 A, di/dt = 11.5 kA/μs, R _G = 5 Ω, V _{GS} = -4 / +18 V, L _S = 30 nH, inductive load	T _{vj} = 25 °C		185		A
			T _{vj} = 125 °C		220		A
			T _{vj} = 175 °C		275		A
Recovery charge 恢复电荷	Q _{rr}		T _{vj} = 25 °C		16.5		μC
			T _{vj} = 125 °C		15		μC
			T _{vj} = 175 °C		21		μC
Reverse recovery time 反向恢复时间	t _{rr}		T _{vj} = 25 °C		65		ns
			T _{vj} = 125 °C		70		ns
			T _{vj} = 175 °C		76		ns
Reverse recovery energy 反向恢复能量	E _{rec}		T _{vj} = 25 °C		6.2		mJ
			T _{vj} = 125 °C		7.4		mJ
			T _{vj} = 175 °C		10.8		mJ

Package properties 封装特性⁷

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Thermal resistance junction to fluid 热阻 结点至流体	R _{th(j-f)}	Per switch, Coolant 50% glycol, 50% water, 10 l/min, dp < 90 mbar			0.11		K/W
Comparative tracking index 相对漏电起痕指数	CTI			400			
Module stray inductance 模块自身杂散电感	L _{s CE}	Per switch			8.5		nH
Resistance, terminal chip 端子到芯片之间的阻抗	R _{CC+EE'}	Per switch	T _{vj} = 25 °C		0.5		mΩ
			T _{vj} = 125 °C				mΩ
			T _{vj} = 175 °C				mΩ
Material of module baseplate 模块底板材料		Ni + Cu Nickel plated Cu baseplate					
Internal isolation 内部绝缘		Si ₃ N ₄ Basic insulation (class 1, IEC 61140)					

⁵ Characteristic values according to IEC 60747-2

⁶ Forward voltage is given at chip-level 正向压降是芯片两端的电压值。

⁷ Package and mechanical properties according to IEC 60747-15



Mechanical properties 机械特性

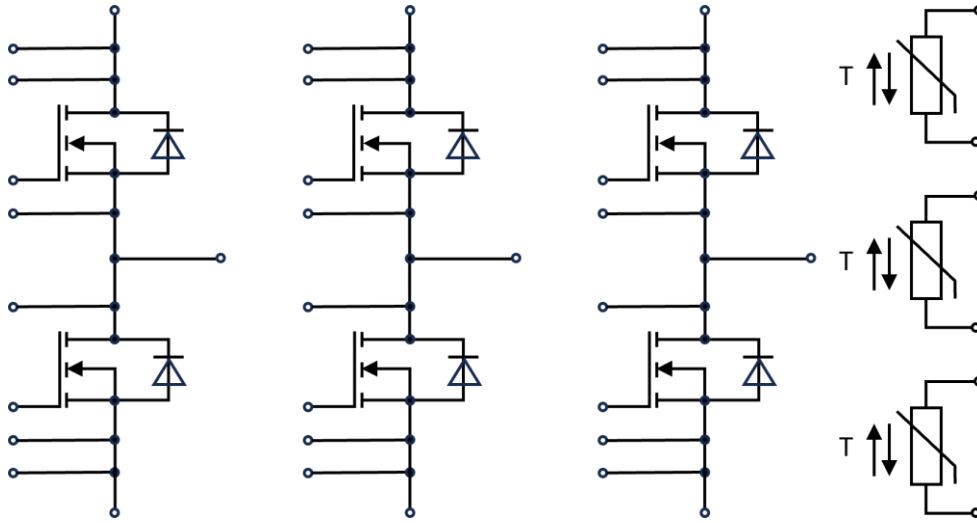
PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Dimensions	L x W x H	Typical		152 x 62 x 17			mm ³
Clearance distance in air 电气间隙	da	According to IEC 60664-1 and EN 50124-1	Terminal to base:	4.5			mm
			Terminal to terminal:	4.5			mm
Surface creepage distance 爬电距离	ds	According to IEC 60664-1 and EN 50124-1	Terminal to base:	9.0			mm
			Terminal to terminal:	9.0			mm
Mass重量	m			720			g

NTC Thermistor

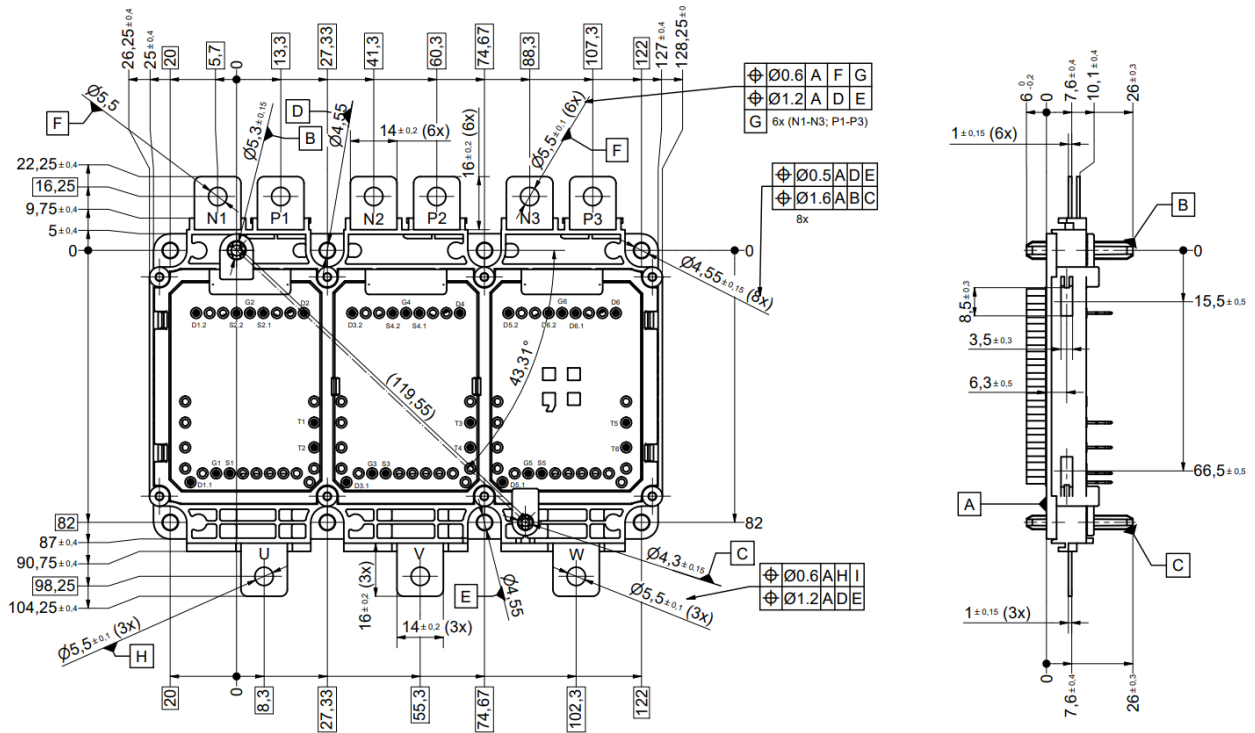
PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Rated resistance 额定电阻	R ₂₅	T _c = 25 °C			5		kΩ
R100	R ₁₀₀	T _c = 100 °C		468		518	Ω
B-value B值	B _{25/50}	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15K))]$			3375		K
B-value B值	B _{25/50}	$R_2 = R_{25} \exp [B_{25/80}(1/T_2 - 1/(298.15K))]$			3411		K
Rated resistance 额定电阻	B _{25/100}	$R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298.15K))]$			3433		K



Electrical configuration 电气图



Outline drawing 外形图



This is an electrostatic sensitive device. 本产品对静电特别敏感
 This product has been designed and qualified for automotive level. 本产品的设计和认证符合汽车级标准



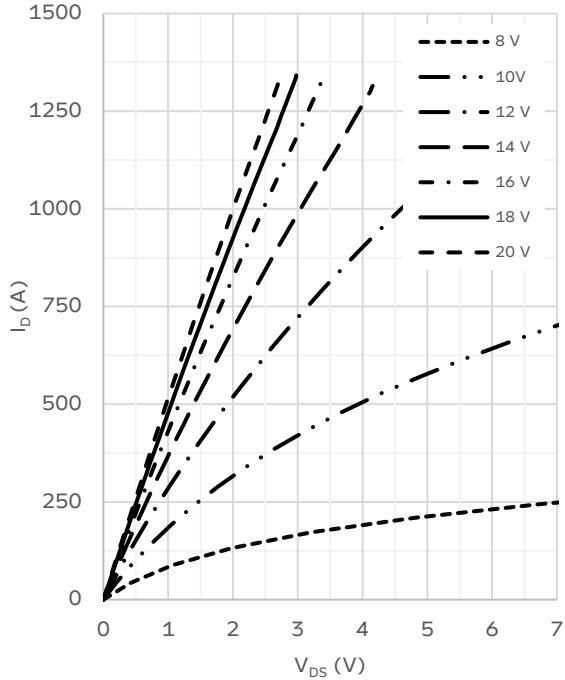
Characteristics 特性曲线

Output characteristics (typical)

输出特性曲线 (典型)

$I_D = f(V_{DS})$

$T_{vj} = 25^\circ\text{C}$

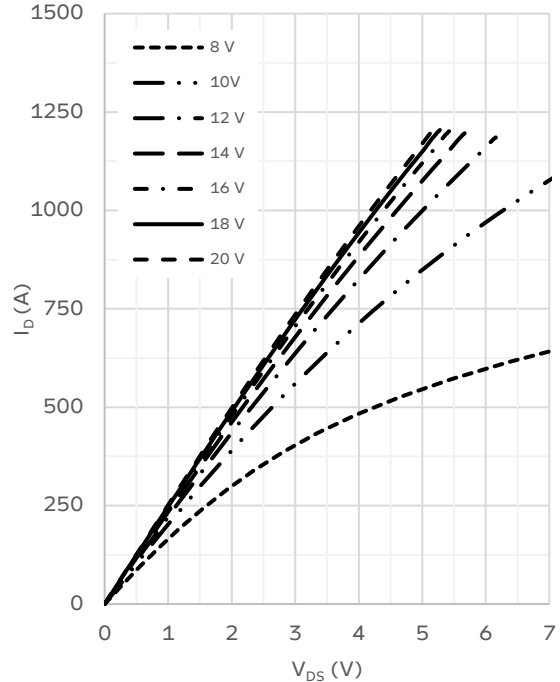


Output characteristics (typical)

输出特性曲线 (典型)

$I_D = f(V_{DS})$

$T_{vj} = 175^\circ\text{C}$

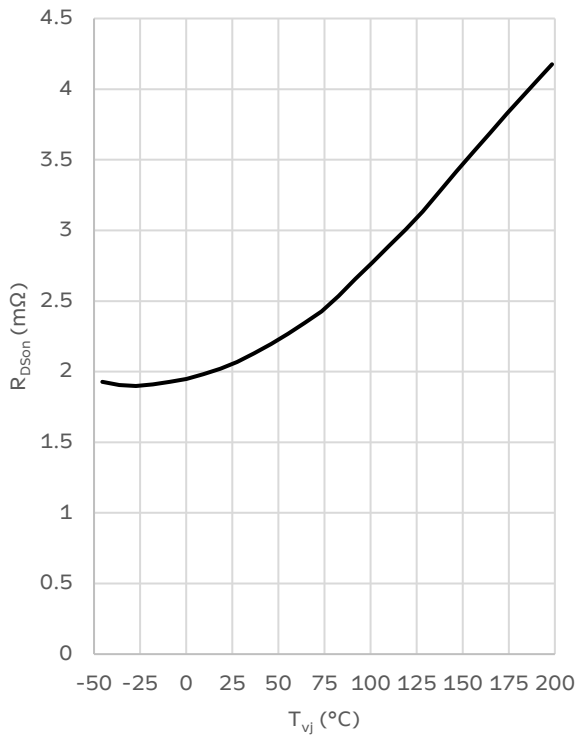


R_{DSon} versus junction temperature (typical)

R_{DSon} 与结温关系 (典型值)

$R_{DSon} = f(T_{vj})$

$I_D = 600\text{ A}$, $V_{GS} = 18\text{ V}$

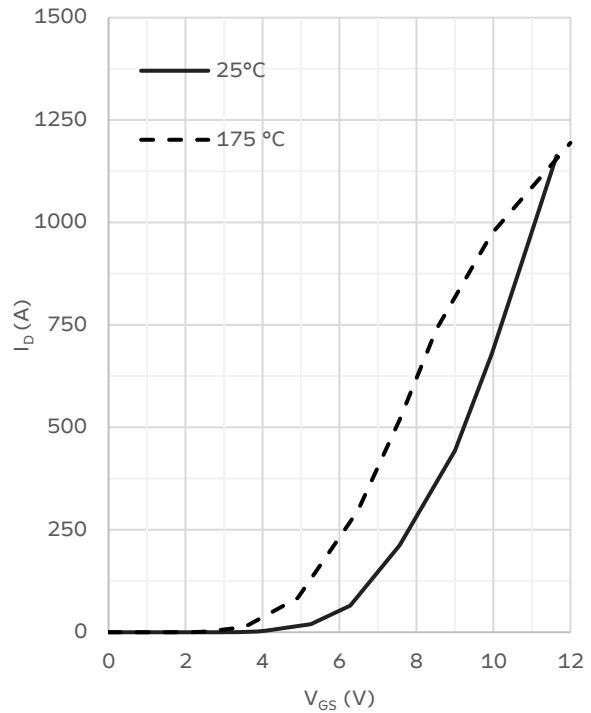


IGBT transfer characteristics (typical)

MOSFET 转移特性曲线 (典型)

$I_D = f(V_{GS})$

$V_{DS} = 6\text{ V}$



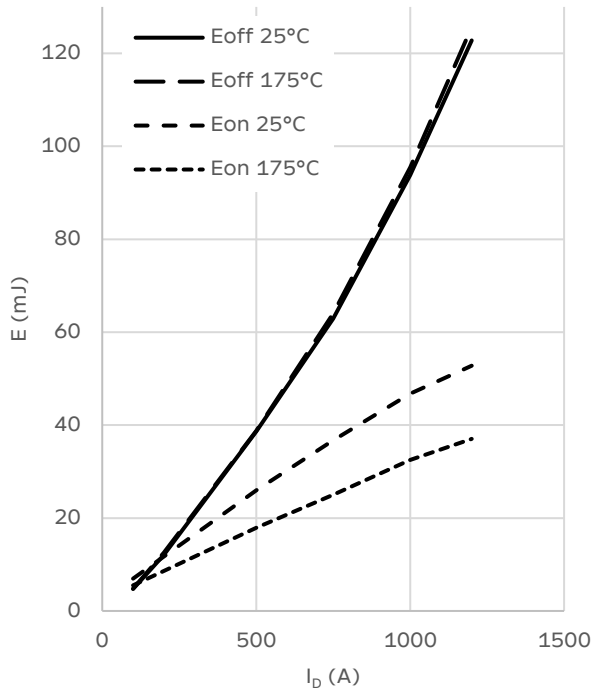


Switching losses (typical)

开关损耗曲线 (典型)

$E = f(I_D)$

$V_{DS} = 800\text{ V}$, $R_{Gon} = 5\ \Omega$, $R_{Goff} = 7\ \Omega$, $V_{GE} = -4/+18\text{ V}$

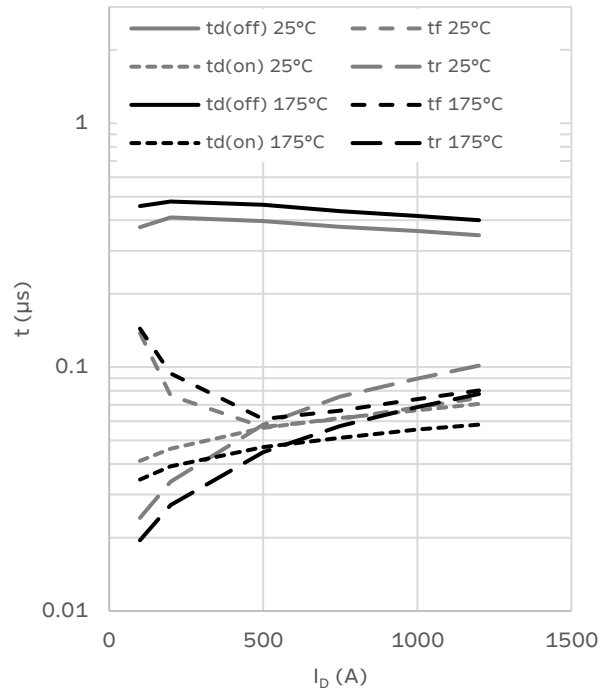


Switching times (typical)

开关时间曲线 (典型)

$t = f(I_D)$

$V_{DS} = 800\text{ V}$, $R_{Gon} = 5\ \Omega$, $R_{Goff} = 7\ \Omega$, $V_{GE} = -4/+18\text{ V}$

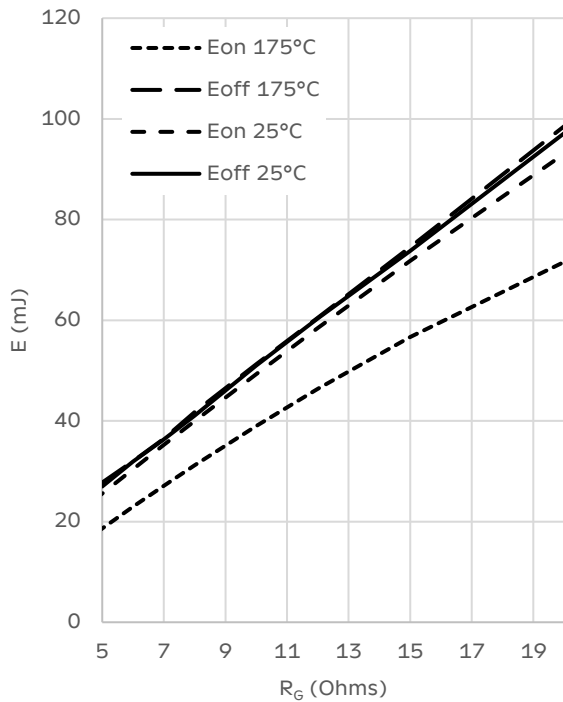


Switching losses (typical)

开关损耗曲线 (典型)

$E = f(R_G)$

$V_{DS} = 800\text{ V}$, $I = 5000\text{ A}$, $V_{GS} = -4/+18\text{ V}$

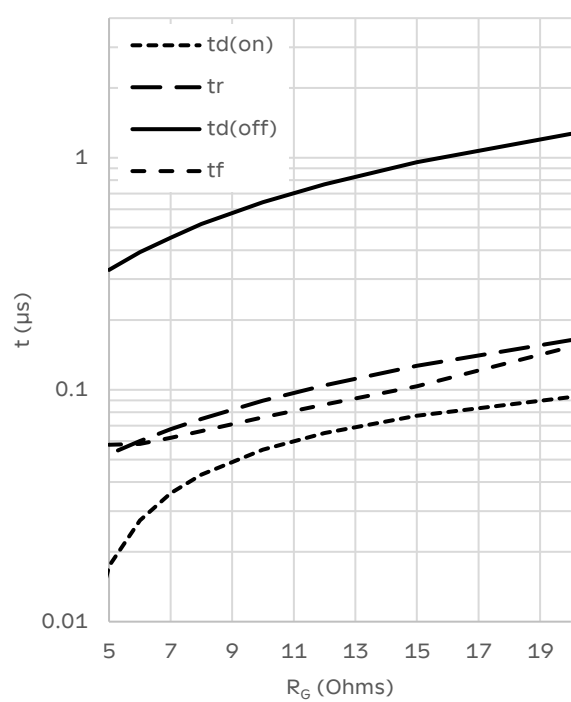


Switching times (typical)

开关时间曲线 (典型)

$t = f(R_G)$, $T_{vj} = 175\ \text{°C}$

$V_{DS} = 800\text{ V}$, $I = 500\text{ A}$, $V_{GS} = -4/+18\text{ V}$



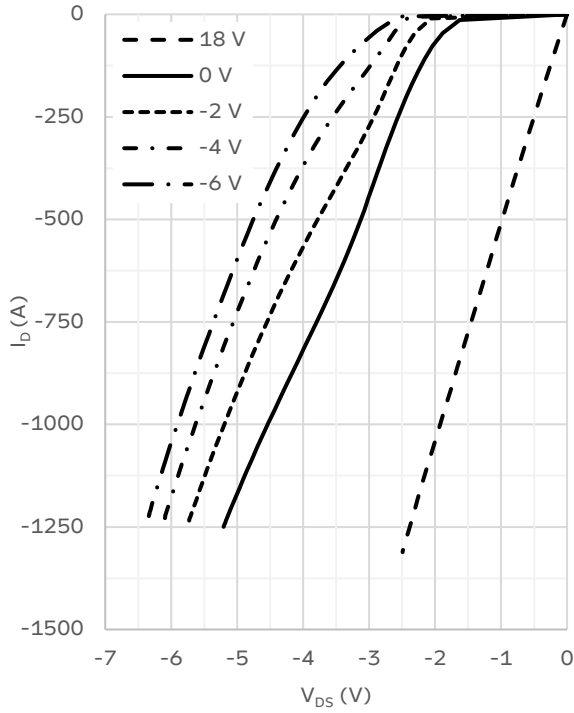


Reverse conduction characteristics (typical)

反向传导特性（典型值）

$I_D = f(V_{DS})$

$T_{vj} = 25^\circ\text{C}$

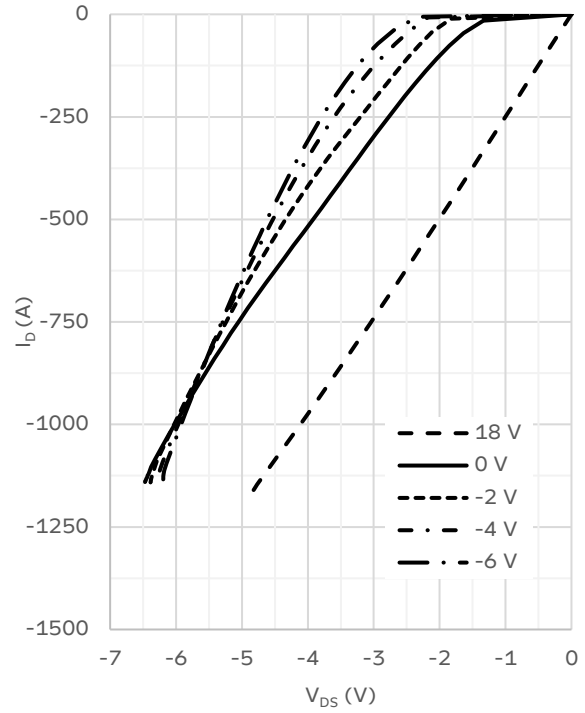


Reverse conduction characteristics (typical)

反向传导特性（典型值）

$I_D = f(V_{DS})$

$T_{vj} = 175^\circ\text{C}$

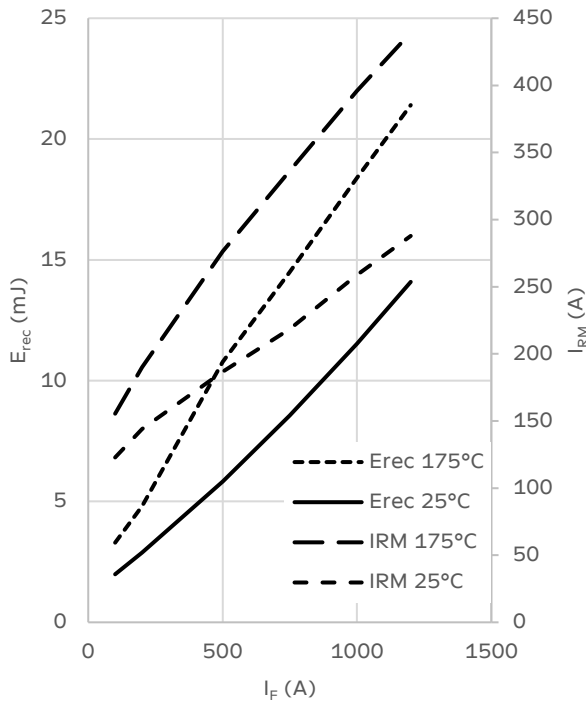


Diode switching characteristics (typical)

二极管开关特性（典型）

$E_{rec} = f(I_F), I_{RM} = f(I_F)$

$V_{DC} = 800\text{ V}, R_{Gon} = 5\ \Omega$ (MOSFET), $V_{GS} = -4/+18\text{ V}$

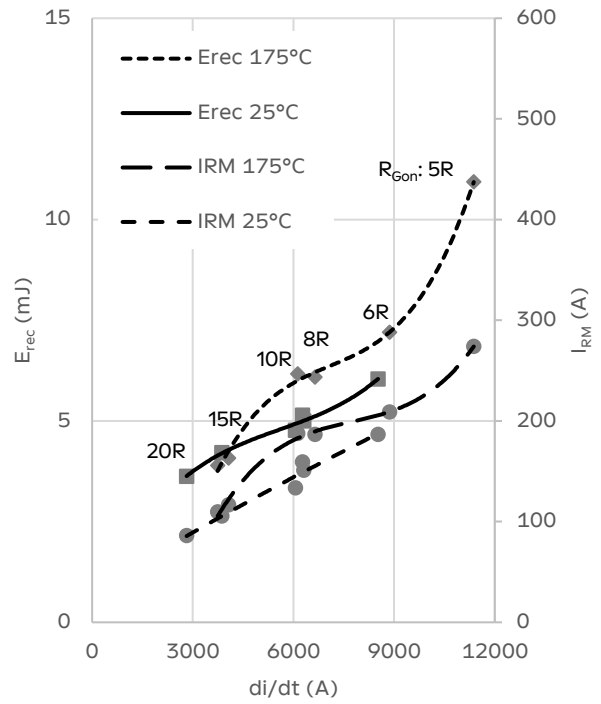


Diode switching characteristics (typical)

二极管开关特性（典型）

$E_{rec} = f(di/dt), I_{RM} = f(di/dt)$

$V_{DC} = 800\text{ V}, I_D = -50\text{ A}, V_{GS} = -4/+18\text{ V}$ (MOSFET)





Thermal resistance versus flow rate

热阻与流速的关系

$$R_{th(J-A)} = f(dv/dt)$$

tbd

Transient thermal impedance

瞬态热阻抗

$$Z_{th(J-A)} = f(t)$$

$$T_F = 50^\circ\text{C}$$

tbd